

Notice of References Cited	Application/Control No. 10/552,688		Applicant(s)/Patent Under Reexamination FUJII, TATSUYA	
	Examiner JEFFREY M. RUTKOWSKI		Art Unit 2473	Page 1 of 1

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	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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